



## Product Change Notification / NTDO-11BSAL752

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**Date:**

25-May-2022

**Product Category:**

Driver / Interface ICs

**PCN Type:**

Manufacturing Change

**Notification Subject:**

CCB 5092 Final Notice: Qualification of MMT as an additional assembly site for selected HV5523K7, HV5623K7, HV5522K7 and HV5622K7 device families available in 44L WQFN (7x7x0.8mm) package.

**Affected CPNs:**

[NTDO-11BSAL752\\_Affected\\_CPN\\_05252022.pdf](#)  
[NTDO-11BSAL752\\_Affected\\_CPN\\_05252022.csv](#)

**Notification Text:**

**PCN Status:**Final Notification

**PCN Type:**Manufacturing Change

**Microchip Parts Affected:**Please open one of the files found in the Affected CPNs section.  
Note: For your convenience Microchip includes identical files in two formats (.pdf and .xls)

**Description of Change:**Qualification of MMT as an additional assembly site for selected HV5523K7, HV5623K7, HV5522K7 and HV5622K7 device families available in 44L WQFN (7x7x0.8mm) package.

**Pre and Post Change Summary:**

	Pre Change	Post Change
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<b>Assembly Site</b>	UTAC Thai Limited (UTL-1) LTD. (NSEB)	Carsem (Suzhou) (CARC)	UTAC Thai Limited (UTL-1) LTD. (NSEB)	Carsem (Suzhou) (CARC)	Microchip Technology Thailand (Branch) (MMT)
<b>Wire Material</b>	CuPdAu	Au	CuPdAu	Au	CuPdAu
<b>Die Attach Material</b>	8600	QMI519	8600	QMI519	3280
<b>Molding Compound Material</b>	G700LTD	EME-G770HCD	G700LTD	EME-G770H CD	G700LTD
<b>MSL information</b>	MSL 1	MSL 3	MSL 1	MSL 3	MSL 1
<b>Lead-Frame Material</b>	EFTEC-64T	A194	EFTEC-64T	A194	A194
<b>Lead-lock</b>	Yes	No	Yes	No	Yes
<b>Lead-frame Paddle Size</b>	217x 217 mils	213x213 mils	217x 217 mils	213x213 mils	213x213 mils
<b>DAP Surface Prep</b>	Ag Ring Plated	Bare Cu	Ag Ring Plated	Bare Cu	Bare Cu
<b>Lead-Frame Drawing</b>	See Pre and Post Change attachment comparison				

**Impacts to Data Sheet:**Yes – Updated POD.

Units: mm		CARC			NSEB			MMT		
		Min	Nom	Max	Min	Nom	Max	Min	Nom	Max
Number of Pins	<b>N</b>	44			44			44		
Pitch	<b>e</b>	0.50 BSC			0.50 BSC			0.50 BSC		
Overall height	<b>A</b>	0.70	0.75	0.80	0.70	0.75	0.80	0.70	0.75	0.80
Stand off (\$)	<b>A1</b>	0.00	0.02	0.05	0.00	-	0.05	0.00	-	0.05
Terminal Thickness	<b>A3</b>	0.203 REF			0.195	0.203	0.261	0.195	0.203	0.261
Overall Length	<b>D</b>	7.00 BSC			6.90	7.00	7.10	6.90	7.00	7.10
Exposed Pad Length	<b>D2</b>	5.00	5.15	5.25	5.10	5.20	5.30	5.10	5.20	5.30
Overall Width	<b>E</b>	7.00 BSC			6.90	7.00	7.10	6.90	7.00	7.10
Exposed Pad Width	<b>E2</b>	5.00	5.15	5.25	5.10	5.20	5.30	5.10	5.20	5.30
Terminal Width	<b>b</b>	0.18	0.25	0.30	0.20	0.25	0.30	0.18	0.23	0.28
Terminal Length	<b>L</b>	0.45	0.55	0.65	0.49	0.50	0.51	0.59	0.64	0.69
Pullback	<b>L1</b>	-	-	-	-	-	-	-	-	-
Mold Angle	<b>Ø</b>	-	-	-	-	-	-	-	-	-
Terminal to Exposed Pad	<b>K</b>	0.20	-	-	-	0.40	-	-	0.26	-

**Change Impact:**None

**Reason for Change:**To improve on-time delivery performance by qualifying MMT as an additional assembly site.

**Change Implementation Status:**In Progress

**Estimated First Ship Date:**May 25, 2022 (date code: 2222)

Note: Please be advised that after the estimated first ship date customers may receive pre and post change parts.

**Time Table Summary:**

	April 2022					May 2022				
Workweek	1 4	1 5	1 6	1 7	1 8	19	2 0	2 1	2 2	23
Initial PCN Issue Date			x							
Qual Report Availability									x	
Final PCN Issue Date									x	

**Method to Identify Change:**Traceability code

**Qualification Report:**Please open the attachments included with this PCN labeled as PCN\_#\_Qual\_Report.

**Revision History:**

**April 12, 2022:** Issued initial notification.

**May 10, 2022:** Updated to correct the POD data of exposed pad size.

**May 25, 2022:** Issued final notification. Attached is the qualification report. Provided estimated first ship date on May 25, 2022.

The change described in this PCN does not alter Microchip's current regulatory compliance regarding the material content of the applicable products.

**Attachments:**

[PCN\\_NTDO-11BSAL752\\_Qual\\_Report.pdf](#)  
[PCN\\_NTDO-11BSAL752\\_Pre and Post Change\\_Summary.pdf](#)

Please contact your local [Microchip sales office](#) with questions or concerns regarding this notification.

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If you wish to change your PCN profile, including opt out, please go to the [PCN home page](#) select login and sign into your myMicrochip account. Select a profile option from the left navigation bar and make the applicable selections.

Affected Catalog Part Numbers (CPN)

HV5523K7-G

HV5523K7-G-M933

HV5623K7-G

HV5623K7-G-M933

HV5522K7-G-S344

HV5622K7-G-S343

**CCB 5092**  
**Pre and Post Change Summary**  
**PCN#: NTDO-11BSAL752**



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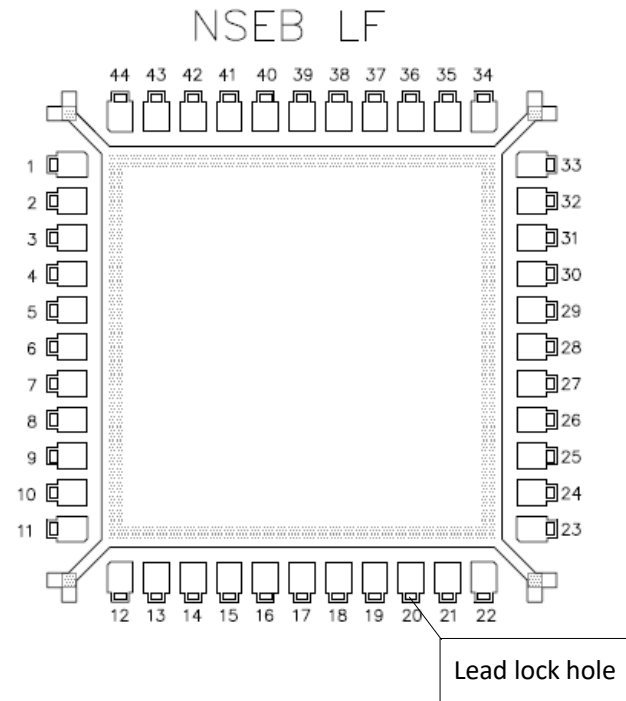
A Leading Provider of Smart, Connected and Secure Embedded Control Solutions



SMART | CONNECTED | SECURE

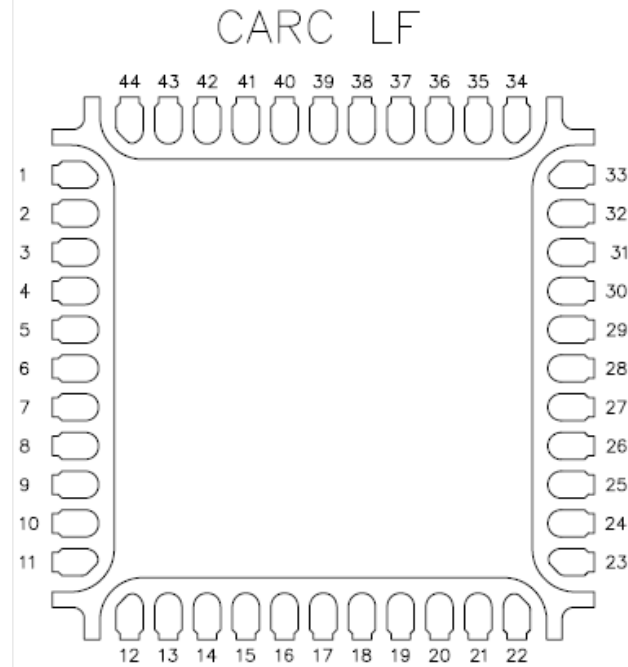
# Lead Frame Comparison

## NSEB



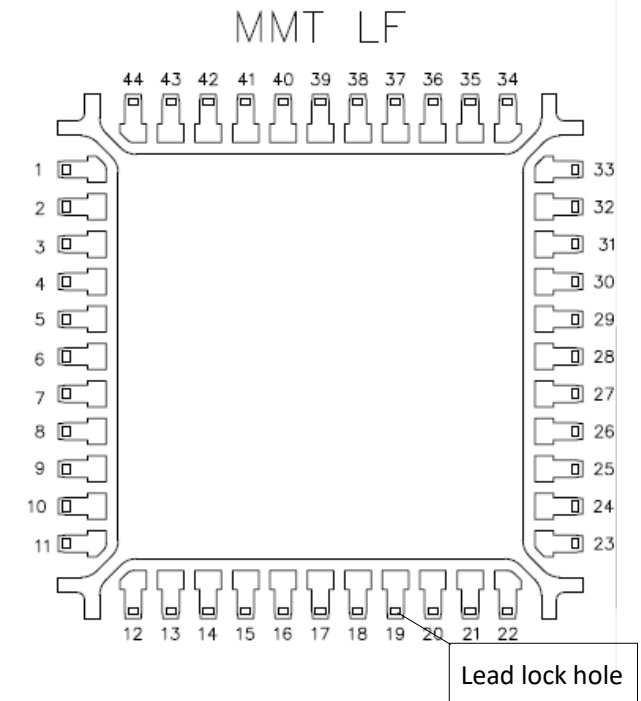
Lead frame material	EFTEC-64T
Lead frame Paddle size	217x 217 mils
Lead-lock (Locking Hole)	Yes

## CARC



Lead frame material	A194
Lead frame Paddle size	213x213 mils
Lead-lock (Locking Hole)	No

## MMT



Lead frame material	A194
Lead frame Paddle size	213x213 mils
Lead-lock (Locking Hole)	Yes

Note: Mold compound material fills the leadlock hole, which provides improved protection against moisture penetration along the edge of the leads (pins) of the package.



**MICROCHIP**

## **QUALIFICATION REPORT SUMMARY**

**PCN#: NTDO-11BSAL752**

**Date**

**May 10, 2022**

**Qualification of MMT as an additional assembly site for selected HV5523K7, HV5623K7, HV5522K7 and HV5622K7 device families available in 44L WQFN (7x7x0.8mm) package.**





## MICROCHIP PACKAGE QUALIFICATION REPORT

<b>Purpose</b>	Qualification of MMT as an additional assembly site for selected HV5523K7, HV5623K7, HV5522K7 and HV5622K7 device families available in 44L WQFN (7x7x0.8mm) package.
<b>CN</b>	E000101694
<b>QUAL ID</b>	R2200350 Rev A
<b>MP CODE</b>	65AA177PXC00
<b>Part No.</b>	HV5524K7-G
<b>Bonding No.</b>	BD-000513 Rev.01
<b>CCB No.</b>	5092
<b><u>Package</u></b>	
<b>Type</b>	44L WQFN
<b>Package size</b>	7 x 7 x 0.8 mm
<b><u>Lead Frame</u></b>	
<b>Paddle size</b>	213 x 213 mils
<b>Material</b>	A194
<b>Surface</b>	Bare Cu
<b>Process</b>	Etched
<b>Lead Lock</b>	Yes
<b>Part Number</b>	10104415
<b>Treatment</b>	BOT
<b><u>Material</u></b>	
<b>Epoxy</b>	3280
<b>Wire</b>	CuPdAu wire
<b>Mold Compound</b>	G700LTD
<b>Plating Composition</b>	Matte Sn



# MICROCHIP PACKAGE QUALIFICATION REPORT

## Manufacturing Information:

Assembly Lot No.	Wafer Lot No.	Date Code
MMT-230102412.000	TMPE220108580.100	2214GV0
MMT-230200397.000	TMPE220108580.100	2215GV1
MMT-230102311.000	TMPE220108580.100	2214D2C

## Result

Pass     Fail     \_\_\_\_\_

44L WQFN (7x7x0.8 mm) assembled by MMT pass reliability test per QCI-39000.  
This package was qualified the Moisture/Reflow Sensitivity Classification Level 1 at 260°C  
reflow temperature per IPC/JEDEC J-STD-020E standard.

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>Precondition Prior Perform Reliability Tests (At MSL Level 1)</b>	<b>Electrical Test:</b> +25°C System: ETS88	JESD22-A113	693(0)	693	Pass	Good Devices
	Bake 150°C, 24 hrs System: CHINEE	JIP/IPC/JEDEC		693		
	85°C/85%RH Moisture Soak 168 hrs. System: TABAI ESPEC Model PR-3SPH	J-STD-020E		693		
	3x Convection-Reflow 265°C max System: Vitronics Soltec MR1243			693		
	<b>Electrical Test:</b> +25°C System: ETS88			0/693		
<b>Temp Cycle</b>	<b>Stress Condition:</b> -65°C to +150°C, 500 Cycles System: TABAI ESPEC TSA-70H	JESD22- A104		231		Parts had been pre-conditioned at 260°C 77 units / lot
	<b>Electrical Test:</b> +25°C System: ETS88		231(0)	0/231	Pass	
	<b>Bond Strength:</b> Wire Pull (>4.00 grams) Bond Shear (>18.00 grams)		15 (0)	0/15	Pass	
			15 (0)	0/15	Pass	
<b>UNBIASED-HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. System: HAST 6000X	JESD22- A118		231		Parts had been pre-conditioned at 260°C 77 units / lot
	<b>Electrical Test:</b> +25°C System: ETS88		231(0)	0/231	Pass	
<b>HAST</b>	<b>Stress Condition:</b> +130°C/85%RH, 96 hrs. <b>Bias Volt:</b> VDD 5.5 Volts, VPP 40 Volts System: HAST 6000X	JESD22- A110		231		Parts had been pre-conditioned at 260°C 77 units / lot
	<b>Electrical Test:</b> +25°C System: ETS88		231(0)	0/231	Pass	

# PACKAGE QUALIFICATION REPORT

Test Number (Reference)	Test Condition	Standard/ Method	Qty. (Acc.)	Def/SS.	Result	Remarks
<b>High Temperature Storage Life</b>	<b>Stress Condition:</b> Bake 175°C, 504 hrs System: SHEL LAB	JESD22- A103		135		45 units / lot
	<b>Electrical Test:</b> +25°C System: ETS88		135(0)	0/135	Pass	
<b>Solderability Temp 215°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping: Solder Temp.215°C Solder material: SnPb Sn63,Pb37 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22 0/22	Pass	
<b>Solderability Temp 245°C</b>	<b>Steam Aging:</b> Temp 93°C,8Hrs System: SAS-3000 Solder Dipping:Solder Temp.245°C Solder material:Pb Free Sn 95.5Ag3.9 Cu0.6 System: ERSA RA 2200D Visual Inspection: External Visual Inspection	J-STD-002	22 (0)	22 22 0/22	Pass	
<b>Wire sweep</b>	Wire sweep Inspection 15 Wires / lot	-	45(0) Wires	0/45	Pass	
<b>Physical Dimensions</b>	Physicalimension, 10 units from 1 lot	JESD22- B100/B108	30(0) Units	0/30	Pass	
<b>Bond Strength Data Assembly</b>	Wire Pull (>4.00 grams)	Mil. Std. 883- 2011	30 (0) Wires	0/30	Pass	
	Bond Shear (>18.00 grams)	CDF-AEC- Q100- 001	30 (0) bonds	0/30	Pass	